

<b>Notice of References Cited</b>	Application/Control No. 10/563,148		Applicant(s)/Patent Under Reexamination TANAKA, YORIO	
	Examiner HAMID R. BADR		Art Unit 1794	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,218,481	08-1980	Chao et al.	426/60
*	B	US-4,266,025	05-1981	Kinast et al.	435/84
*	C	US-5,728,549	03-1998	Liersch et al.	435/69.2
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	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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	N					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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